MOSFET – Power, Single N-Channel, μ8FL 30 V, 5.9 mΩ, 55 A

Features

- Low R_{DS(on)} to Minimize Conduction Losses
- Low Capacitance to Minimize Driver Losses
- Optimized Gate Charge to Minimize Switching Losses
- NVTFS4C08NWF Wettable Flanks Product
- NVT Prefix for Automotive and Other Applications Requiring Unique Site and Control Change Requirements; AEC-Q101 Qualified and PPAP Capable
- These Devices are Pb–Free, Halogen Free/BFR Free and are RoHS Compliant

MAXIMUM RATINGS (T_J = 25°C unless otherwise stated)

| Param | Symbol | Value | Unit | | |
|--|--|------------------------|--------------------------------------|----------------|----|
| Drain-to-Source Voltage | | | V_{DSS} | 30 | V |
| Gate-to-Source Voltage | | | V _{GS} | ±20 | V |
| Continuous Drain Current R _{BJA} | | T _A = 25°C | I _D | 17 | Α |
| (Notes 1, 2, 4) | | T _A = 100°C | | 12 | |
| Power Dissipation R _{θJA} | | | P_{D} | 3.1 | W |
| (Note 1, 2, 4) | Steady | T _A = 100°C | | 1.6 | |
| Continuous Drain Current R _{0JC} (Note 1, | State | T _A = 25°C | I _D | 55 | |
| 3, 4) | | T _A = 100°C | | 39 | Α |
| Power Dissipation | | T _A = 25°C | P_{D} | 31 | W |
| R _{θJC} (Note 1, 3, 4) | | T _A = 100°C | | 15 | |
| Pulsed Drain Current | Current $T_A = 25^{\circ}C$, $t_p = 10 \mu s$ | | | 253 | Α |
| Operating Junction and Storage Temperature | | | T _J , T _{stg} | –55 to +175 | °C |
| Source Current (Body Did | I _S | 28 | Α | | |
| Single Pulse Drain-to-Source Avalanche Energy $(T_J = 25^{\circ}C, I_L = 20 A_{pk}, L = 0.1 \text{ mH})$ | | | E _{AS} | 20 | mJ |
| Lead Temperature for Soldering Purposes (1/8" from case for 10 s) | | | TL | 260 | °C |

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

THERMAL RESISTANCE MAXIMUM RATINGS

| Parameter | Symbol | Value | Unit |
|---|-----------------|-------|------|
| Junction-to-Case - Steady State (Drain) (Notes 1 and 4) | $R_{\theta JC}$ | 4.9 | °C/W |
| Junction-to-Ambient - Steady State (Notes 1 and 2) | $R_{\theta JA}$ | 48 | 0/11 |

- The entire application environment impacts the thermal resistance values shown, they are not constants and are only valid for the particular conditions noted.
- 2. Surface-mounted on FR4 board using a 650 mm² 2 oz. Cu pad.
- Assumes heat-sink sufficiently large to maintain constant case temperature independent of device power.
- Continuous DC current rating. Maximum current for pulses as long as 1 second is higher but is dependent on pulse duration and duty cycle.

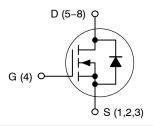


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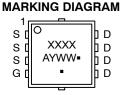
| V _{(BR)DSS} | R _{DS(on)} MAX | I _D MAX | |
|----------------------|-------------------------|--------------------|--|
| 30 V | 5.9 mΩ @ 10 V | 55 A | |
| 30 V | 9.0 mΩ @ 4.5 V | 33 A | |

N-Channel MOSFET





WDFN8 (μ8FL) CASE 511AB



4C08 = Specific Device Code for

NVMTS4C08N

08WF = Specific Device Code of

NVTFS4C08NWF

A = Assembly Location

Y = Year WW = Work

WW = Work Week = Pb-Free Package

(Note: Microdot may be in either location)

ORDERING INFORMATION

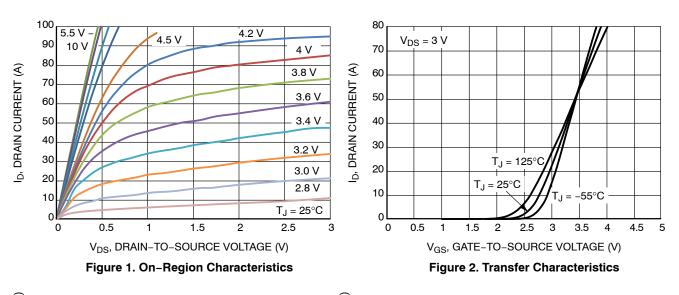
See detailed ordering and shipping information on page 5 of this data sheet.

ELECTRICAL CHARACTERISTICS ($T_J = 25^{\circ}C$ unless otherwise specified)

| OFF CHARACTERISTICS Vigriposs V _{GS} = 0 V, I _D = 250 μA 30 V Drain-10Source Breakdown Voltage Temperature Coefficient Properture Coefficient Pr | Parameter | Symbol | Test Condition | | Min | Тур | Max | Unit |
|---|--|-------------------------------------|---|----------------------------|-----|-------|------|----------------|
| Design Continue | OFF CHARACTERISTICS | | | | | | | |
| Temperature Coefficient Tourish Tourish | Drain-to-Source Breakdown Voltage | V _{(BR)DSS} | V _{GS} = 0 V, I _D = 250 μA | | 30 | | | V |
| A | | V _{(BR)DSS} / | | | | 13.8 | | mV/°C |
| A | Zero Gate Voltage Drain Current | I _{DSS} | V _{GS} = 0 V, | T _J = 25°C | | | 1.0 | μΑ |
| ON CHARACTERISTICS (Note 5) VGS(TH)/TJ VGS = VDS, ID = 250 μA 1.3 2.2 V Negative Threshold Temperature Coefficient Drain-to-Source On Resistance RDS(m) VGS = 10 V ID = 30 A 4.7 5.9 mV/°C Drain-to-Source On Resistance RDS(m) VGS = 1.5 V, ID = 1.5 A 4.2 9.0 MC2 Forward Transconductance BFS VDS = 1.5 V, ID = 1.5 A 4.2 4.2 9.0 Forward Transconductance BG TA = 25° V 1.0 4.2 9.0 Gate Resistance CB TA = 25° V 1.0 4.2 9.0 CHARGES AND CAPACITANCES TITIS TA = 25° V 1.113 7.02 1.0 Cutput Capacitance CISS VGS = 0 V, I = 1 MHz, VDS = 15 V 7.02 1.0 <td></td> <td></td> <td>V_{DS} = 24 V</td> <td>T_J = 125°C</td> <td></td> <td></td> <td>10</td> | | | V _{DS} = 24 V | T _J = 125°C | | | 10 | |
| Negative Threshold Voltage Vas(π) Vas = V | Gate-to-Source Leakage Current | I _{GSS} | $V_{DS} = 0 V, V_{GS}$ | = ±20 V | | | ±100 | nA |
| Negative Threshold Temperature Coefficient V _{GS(TH)} /T _J V _{GS} = 10 V D _B = 30 A 4.7 5.9 mΩ C S S S S S S S S S | | | | | | | | |
| Description | Gate Threshold Voltage | V _{GS(TH)} | $V_{GS} = V_{DS}, I_D =$ | = 250 μΑ | 1.3 | | 2.2 | V |
| Forward Transconductance 9Fs V _{GS} = 4.5 V I _D = 18 A 7.2 9.0 Poward Transconductance 9Fs V _{DS} = 1.5 V, I _D = 15 A 42 S S | Negative Threshold Temperature Coefficient | V _{GS(TH)} /T _J | | | | 5.0 | | mV/°C |
| V _{GS} = 4.5 V I _D = 18 A 7.2 9.0 | Drain-to-Source On Resistance | R _{DS(on)} | V _{GS} = 10 V | I _D = 30 A | | 4.7 | 5.9 | 0 |
| Cate Resistance Rg TA = 25°C 1.0 Ω Ω | | | V _{GS} = 4.5 V | I _D = 18 A | | 7.2 | 9.0 | - mΩ |
| The property is a content of the prepresentation of the property is a content of the property is a c | Forward Transconductance | 9 _{FS} | V _{DS} = 1.5 V, I _D | ₎ = 15 A | | 42 | | S |
| Input Capacitance | Gate Resistance | R_{G} | T _A = 25°0 | С | | 1.0 | | Ω |
| Output Capacitance Coss Caps VGS = 0 V, f = 1 MHz, VDS = 15 V 702 pF Reverse Transfer Capacitance CRSS 39 30 | CHARGES AND CAPACITANCES | | | | | | | |
| Reverse Transfer Capacitance C | Input Capacitance | C _{ISS} | | | | 1113 | | |
| $ \begin{array}{c ccccccccccccccccccccccccccccccccccc$ | Output Capacitance | Coss | V _{GS} = 0 V, f = 1 MH; | z, V _{DS} = 15 V | | 702 | | pF |
| $ \begin{array}{ c c c c c c c c c c c c c c c c c c c$ | Reverse Transfer Capacitance | C _{RSS} | 1 | | | 39 | | |
| $ \begin{array}{ c c c c c c c c c c c c c c c c c c c$ | Capacitance Ratio | C _{RSS} /C _{ISS} | V _{GS} = 0 V, V _{DS} = 15 V, f = 1 MHz | | | 0.035 | | |
| $ \begin{array}{c ccccccccccccccccccccccccccccccccccc$ | Total Gate Charge | Q _{G(TOT)} | | | | 8.4 | | nC |
| $ \begin{array}{c ccccccccccccccccccccccccccccccccccc$ | Threshold Gate Charge | Q _{G(TH)} | 1 | | | 1.8 | | |
| Gate Plateau Voltage V _{GP} 3.4 V Total Gate Charge $Q_{G(TOT)}$ $V_{GS} = 10 \text{ V}, V_{DS} = 15 \text{ V}; I_D = 30 \text{ A}$ 18.2 nC SWITCHING CHARACTERISTICS (Note 6) Turn-On Delay Time $t_{d(ON)}$ $V_{GS} = 4.5 \text{ V}, V_{DS} = 15 \text{ V}, I_D = 30 \text{ A}$ 9.0 | Gate-to-Source Charge | Q_{GS} | V _{GS} = 4.5 V, V _{DS} = 1 | 5 V; I _D = 30 A | | 3.5 | | |
| $ \begin{array}{ c c c c c c c c c c c c c c c c c c c$ | Gate-to-Drain Charge | Q_{GD} | 1 | | | 3.3 | | |
| $ \begin{array}{c ccccccccccccccccccccccccccccccccccc$ | Gate Plateau Voltage | V_{GP} | 1 | | | 3.4 | | V |
| $ \begin{array}{c ccccccccccccccccccccccccccccccccccc$ | Total Gate Charge | Q _{G(TOT)} | V _{GS} = 10 V, V _{DS} = 15 V; I _D = 30 A | | | 18.2 | | nC |
| $ \begin{array}{c ccccccccccccccccccccccccccccccccccc$ | SWITCHING CHARACTERISTICS (Note 6) | | | | | • | | • |
| $ \begin{array}{c ccccccccccccccccccccccccccccccccccc$ | Turn-On Delay Time | t _{d(ON)} | | | | 9.0 | | |
| $ \begin{array}{c ccccccccccccccccccccccccccccccccccc$ | Rise Time | t _r | VGS = 4.5 V. VDS | s = 15 V. | | 33 | | ns |
| $ \begin{array}{c ccccccccccccccccccccccccccccccccccc$ | Turn-Off Delay Time | t _{d(OFF)} | I _D = 15 A, R _G = | = 3.0 Ω | | 15 | | |
| $ \begin{array}{c ccccccccccccccccccccccccccccccccccc$ | Fall Time | t _f | 1 | | | 4.0 | | |
| $ \begin{array}{c ccccccccccccccccccccccccccccccccccc$ | Turn-On Delay Time | t _{d(ON)} | | | | 7.0 | | |
| $ \begin{array}{c ccccccccccccccccccccccccccccccccccc$ | Rise Time | | V_{GS} = 10 V, V_{DS} = 15 V, I_D = 15 A, R_G = 3.0 Ω | | | 26 | | - ns |
| $ \begin{array}{c ccccccccccccccccccccccccccccccccccc$ | Turn-Off Delay Time | t _{d(OFF)} | | | | 19 | | |
| $ \begin{array}{c ccccccccccccccccccccccccccccccccccc$ | Fall Time | | | | | 3.0 | | |
| $\begin{array}{c ccccccccccccccccccccccccccccccccccc$ | DRAIN-SOURCE DIODE CHARACTERISTICS | | | | | | | |
| | Forward Diode Voltage | V_{SD} | VGS - 0 V, | | | 0.79 | 1.1 | |
| $\begin{array}{c ccccccccccccccccccccccccccccccccccc$ | | | | | | 0.66 | | 1 ^v |
| Discharge Time t_b $l_S = 30 \text{ A}$ 13.8 | Reverse Recovery Time | t _{RR} | | | | 28.3 | | |
| Discharge Time t _b Is = 30 A 13.8 | Charge Time | | | | | 14.5 | | ns |
| Reverse Recovery Charge Q _{RR} 15.3 nC | Discharge Time | | | | | 13.8 | | |
| | Reverse Recovery Charge | Q_{RR} | | | | 15.3 | | nC |

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions. 5. Pulse Test: pulse width $\leq 300~\mu s$, duty cycle $\leq 2\%$. 6. Switching characteristics are independent of operating junction temperatures.

TYPICAL CHARACTERISTICS



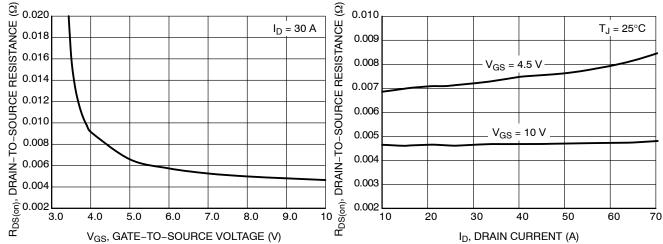


Figure 3. On-Resistance vs. V_{GS}

Figure 4. On-Resistance vs. Drain Current and Gate Voltage

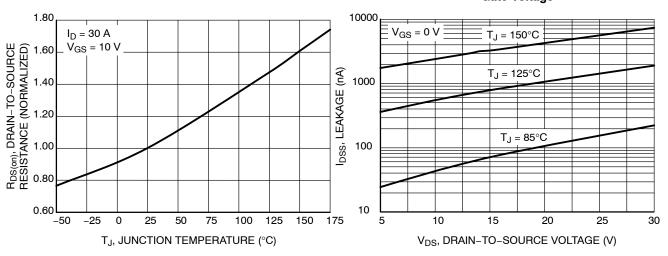


Figure 5. On–Resistance Variation with Temperature

Figure 6. Drain-to-Source Leakage Current vs. Voltage

TYPICAL CHARACTERISTICS

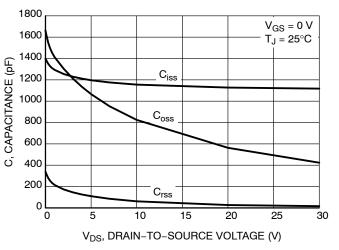


Figure 7. Capacitance Variation

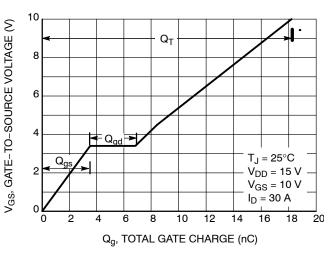


Figure 8. Gate-to-Source and Drain-to-Source Voltage vs. Total Charge

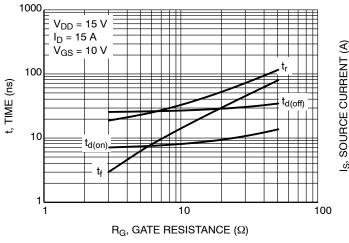


Figure 9. Resistive Switching Time Variation vs. Gate Resistance

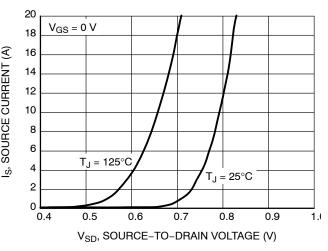


Figure 10. Diode Forward Voltage vs. Current

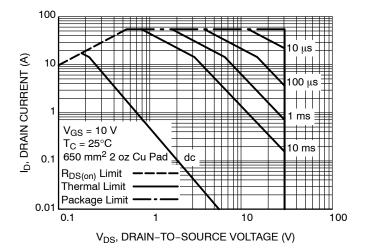


Figure 11. Maximum Rated Forward Biased Safe Operating Area

TYPICAL CHARACTERISTICS

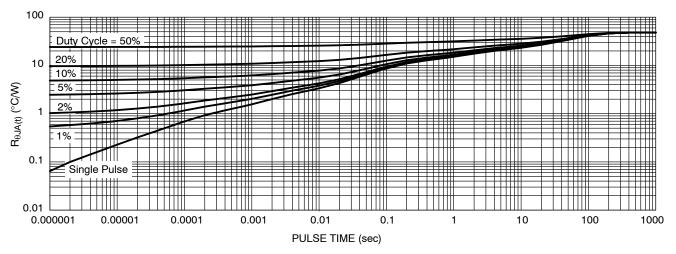


Figure 12. Thermal Response

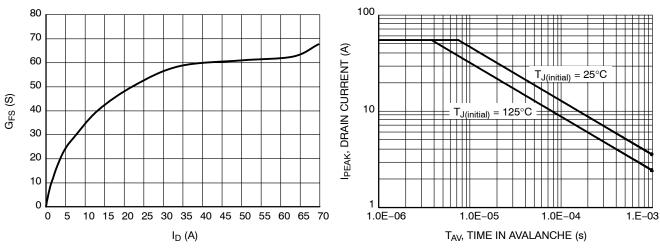


Figure 13. G_{FS} vs. I_D

Figure 14. Avalanche Characteristics

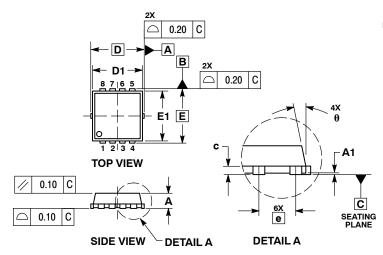
ORDERING INFORMATION

| Device | Package | Shipping [†] |
|-----------------|--------------------|-----------------------|
| NVTFS4C08NTAG | WDFN8 (Pb-Free) | 1500 / Tape & Reel |
| NVTFS4C08NWFTAG | WDFN8 (Pb-Free) | 1500 / Tape & Reel |
| NVTFS4C08NTWG | WDFN8 (Pb-Free) | 5000 / Tape & Reel |
| NVTFS4C08NWFTWG | WDFN8 (Pb-Free) | 5000 / Tape & Reel |

[†]For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

PACKAGE DIMENSIONS

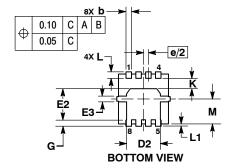
WDFN8 3.3x3.3, 0.65P CASE 511AB ISSUE D



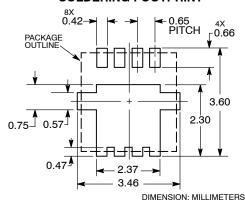
NOTES:

- 1. DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 1994. 2. CONTROLLING DIMENSION: MILLIMETERS.
- DIMENSION D1 AND E1 DO NOT INCLUDE MOLD FLASH PROTRUSIONS OR GATE BURRS.

| | МІ | LLIMETE | RS | INCHES | | | |
|-----|----------|----------|------|-----------|-------|-------|--|
| DIM | MIN | NOM | MAX | MIN | NOM | MAX | |
| Α | 0.70 | 0.75 | 0.80 | 0.028 | 0.030 | 0.031 | |
| A1 | 0.00 | | 0.05 | 0.000 | | 0.002 | |
| b | 0.23 | 0.30 | 0.40 | 0.009 | 0.012 | 0.016 | |
| С | 0.15 | 0.20 | 0.25 | 0.006 | 0.008 | 0.010 | |
| D | 3.30 BSC | | | 0.130 BSC | | | |
| D1 | 2.95 | 3.05 | 3.15 | 0.116 | 0.120 | 0.124 | |
| D2 | 1.98 | 2.11 | 2.24 | 0.078 | 0.083 | 0.088 | |
| E | | 3.30 BSC | ; | 0.130 BSC | | | |
| E1 | 2.95 | 3.05 | 3.15 | 0.116 | 0.120 | 0.124 | |
| E2 | 1.47 | 1.60 | 1.73 | 0.058 | 0.063 | 0.068 | |
| E3 | 0.23 | 0.30 | 0.40 | 0.009 | 0.012 | 0.016 | |
| е | 0.65 BSC | | | 0.026 BSC | | | |
| G | 0.30 | 0.41 | 0.51 | 0.012 | 0.016 | 0.020 | |
| K | 0.65 | 0.80 | 0.95 | 0.026 | 0.032 | 0.037 | |
| L | 0.30 | 0.43 | 0.56 | 0.012 | 0.017 | 0.022 | |
| L1 | 0.06 | 0.13 | 0.20 | 0.002 | 0.005 | 0.008 | |
| M | 1.40 | 1.50 | 1.60 | 0.055 | 0.059 | 0.063 | |
| θ | 0 ° | | 12 ° | 0 ° | | 12 ° | |



SOLDERING FOOTPRINT*



*For additional information on our Pb-Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

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